

UNISONIC TECHNOLOGIES CO., LTD

UT4466 Preliminary Power MOSFET

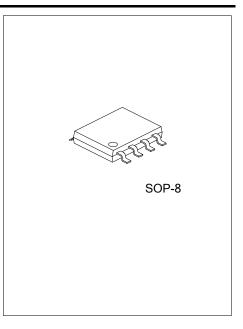
10A, 30V N-CHANNEL ENHANCEMENT MODE MOSFET

■ DESCRIPTION

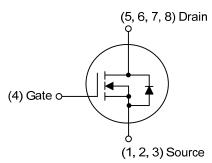
The UTC **UT4466** is an N-channel Power FET, it uses UTC's advanced technology to provide customers a minimum on-state resistance, high switching speed and low gate charge.

■ FEATURES

- * $R_{DS(ON)}$ < 15m Ω @ V_{GS} =10V, I_D =10A
- * High switching speed
- * Low gate charge (Typ.=10.5nC)



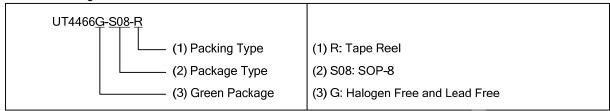
■ SYMBOL



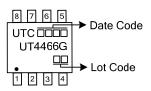
■ ORDERING INFORMATION

Ordering Number	Package	Pin Assignment							Doolsing	
		1	2	3	4	5	6	7	8	Packing
UT4466G-S08-R	SOP-8	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

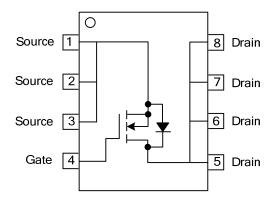


■ MARKING



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PIN CONFIGURATION





■ ABSOLUTE MAXIMUM RATINGS (T_A=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Volt	age	V_{DSS}	$V_{\rm DSS}$ 30		
Gate-Source Volta	Source Voltage		±25	V	
Drain Current	T _A =25°C	- I _D	10	Α	
	Continuous(Note 2) $\frac{T_A=25^{\circ}C}{T_A=85^{\circ}C}$		6	Α	
	Pulsed (Note 3)	I _{DM}	60	Α	
Avalanche Curren	t (Note 3, 4)	I _{AR}			
Repetitive Avalance	ve Avalanche Energy (Note 3, 4) L=0.1mH E _{AR} 12.8		12.8	mJ	
Power Dissipation	(Note 2)	P_{D}			
Junction Tempera	unction Temperature		-55~+150	°C	
Storage Temperature Range		T _{STG}	-55~+150	°C	

- Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 - 2. Device mounted on FR-4 substrate PC board with minimum recommended pad layout in a still air environment @ T_A =25°C. The value in any given application depends on the user's specific board design.
 - 3. Repetitive rating, pulse width limited by junction temperature.
 - 4. I_{AR} and E_{AR} rating are based on low frequency and duty cycles to keep T_J=25°C

■ THERMAL CHARACTERISTICS (T_A=25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient (Note 1)	θ_{JA}	88.4	°C/W

■ ELECTRICAL CHARACTERISTICS (T_A=25°C, unless otherwise specified)

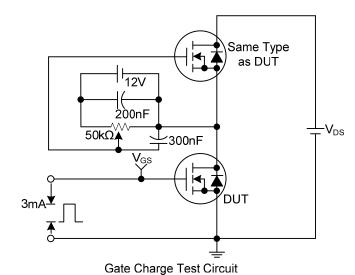
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS (Note 1)								
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	30			V	
Drain-Source Leakage Current		I _{DSS}	V _{DS} =30V, V _{GS} =0V			1	μA	
Gate-Source Leakage Current	Forward		V _{GS} =+25V, V _{DS} =0V			+100	nA	
	Reverse	I_{GSS}	V _{GS} =-25V, V _{DS} =0V			-100	nA	
ON CHARACTERISTICS (Note 1)								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1.0	1.45	2.4	V	
Static Drain-Source On-State Resist	ociatanaa	R _{DS(ON)}	V _{GS} =10V, I _D =10A		15	23	mΩ	
	esistance		V _{GS} =4.5V, I _D =7.5A		25	33	mΩ	
Forward Transfer Admittance		Y _{FS}	V_{DS} =5V, I_D =10A		2.5		S	
DYNAMIC PARAMETERS (Not	e 2)							
Input Capacitance		C _{ISS}			478.9		pF	
Output Capacitance Reverse Transfer Capacitance		Coss	V_{GS} =0V, V_{DS} =15V, f=1.0MHz		96.7		pF	
		C_{RSS}			61.4		pF	
SWITCHING PARAMETERS								
Gate Resistance		R_G	V _{DS} =0V, V _{GS} =0V, f=1MHz	0.4	1.1	1.6	Ω	
Total Gate Charge		Q_G	V_{GS} =4.5V, V_{DS} =15V, I_{D} =10A		5.0	8	nC	
Total Gate Charge		Q_G			10.5	17	nC	
Gate to Source Charge		Q_GS	V _{GS} =10V, V _{DS} =15V, I _D =10A		1.8		nC	
Gate to Drain Charge		Q_{GD}	4		1.6		nC	
Turn-ON Delay Time		t _{D(ON)}	115		2.9		ns	
Rise Time Turn-OFF Delay Time Fall-Time		t _R	V_{DS} =15V, V_{GS} =10V, R_{G} =3 Ω ,	\mathcal{I}_{II} .	7.9		ns	
		t _{D(OFF)}	R _L =1.5Ω		14.6		ns	
		t _F	(学) 100		3.1		ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Drain-Source Diode Forward Vo	ltage	V _{SD}	I _S =1A, V _{GS} =0V		0.69	1	V	

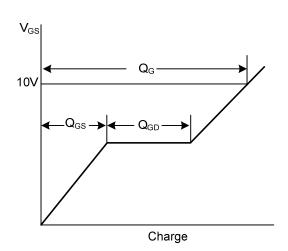
Notes: 1. Short duration pulse test used to minimize self-heating effect.

2. Guaranteed by design. Not subject to production testing.

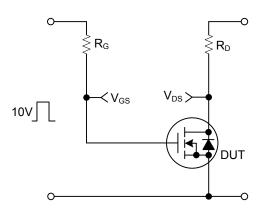


TEST CIRCUITS AND WAVEFORMS

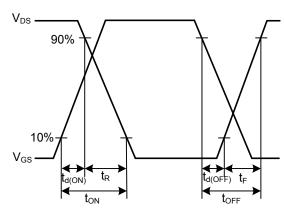




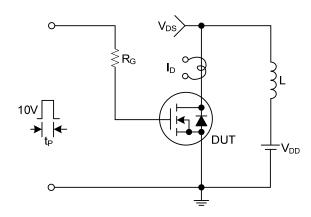
Gate Charge Waveforms



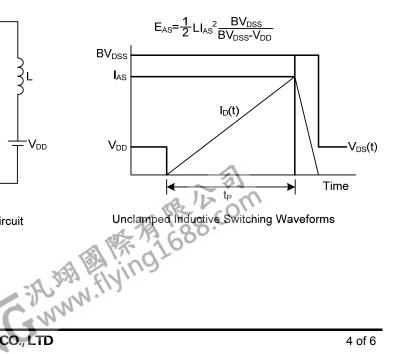
Resistive Switching Test Circuit



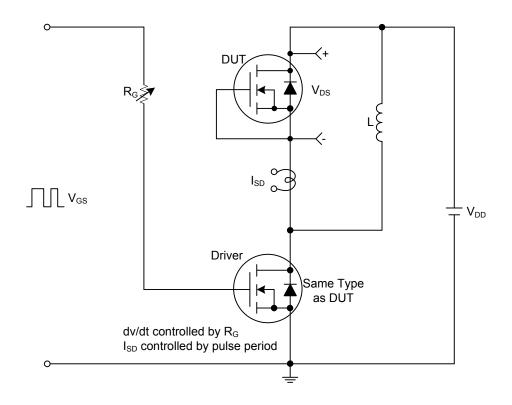
Resistive Switching Waveforms

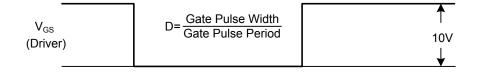


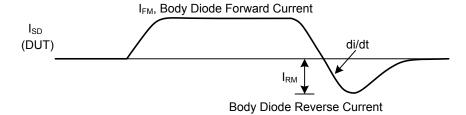
Unclamped Inductive Switching Test Circuit

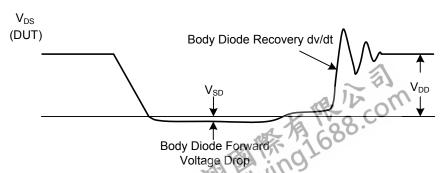


■ TEST CIRCUITS AND WAVEFORMS(Cont.)









Peak Diode Recovery dv/dt Test Circuit and Waveforms

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